FCC PART 15B MEASUREMENT AND TEST REPORT FOR

ENCORE ELECTRONICS INC.

16483 Old Valley Blvd., La Puente, CA 91744, USA

FCC ID: YZ50000008

Report Concerns:	Equipment Type:	
Original Report	Wireless N150 PCI Adapter	
Model:	ENLWI-1XN42	
Report No.:	<u>STR11128387I-1</u>	
Test Date:	2011-12-27 to 2012-01-08	
Issue Date:	<u>2012-02-06</u>	
Tested By:	Vigoss Xiong / Engineer	Vigess Xiong Lahm peng Jundyso
Reviewed By:	Lahm Peng / EMC Manager	Lahm peng
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Note: This test report is limited to the above client company and the product model only. It may not be duplicated without prior permitted by SEM.Test Compliance Service Co., Ltd.

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1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

Client Information	
Applicant:	ENCORE ELECTRONICS INC
Address of applicant:	16483 Old Valley Blvd., La Puente, CA 91744, USA
Manufacturer:	Sun Rise Electronic Factory
Address of manufacturer:	LanYuan Road, ZengTian Industrial District, XinAn
	Community, ChangAn Town, DongGuan City, GuangDong
	Province, China

General Description of E.U.T

Items	Description	
EUT Description:	Wireless N150 PCI Adapter	
Trade Name:	ENCORE	
Model No.:	ENLWI-1XN42	
Rated Voltage:	DC 3.3V	
Type of Antenna:	External Antenna	
For more information refer to the circuit diagram form and the user's manual.		

The test data is gathered from a production sample, provided by the manufacturer.

1.2 Test Standards

The following report is prepared on behalf of the ENCORE ELECTRONICS INC in accordance with Part 2, Subpart J, and Part 15, Subparts A and B of the Federal Communication Commissions rules.

The objective is to determine compliance with FCC Part 15.107, and 15.109 rules.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which results in lowering the emission/immunity, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

The equipment under test (EUT) was configured to measure its highest possible susceptibility against the tested phenomena. The test modes were adapted accordingly in reference to the Operating Instructions.

1.4 Test Facility

• FCC – Registration No.: 994117

SEM.Test Compliance Services Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files and the Registration is 994117.

• Industry Canada (IC) Registration No.: 7673A

The 3m Semi-anechoic chamber of SEM.Test Compliance Services Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 7673A.

• CNAS Registration No.: L4062

Shenzhen SEM.Test Electronics Service Co., Ltd. is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L4062. All measurement facilities used to collect the measurement data are located at 3/F, Jinbao Commerce Building, Xin'an Fanshen Road, Bao'an District, Shenzhen, P.R.C (518101)

1.5 EUT Exercise Software

The EUT exercise program used during radiated and conducted testing was designed to exercise the system components. The test software, provided by the customer, is started while the EUT is on to simulate the normal work. under the Windows XP terminal.

1.6 Accessories Equipment List and Details

Description	Manufacturer	Model	Serial Number
DELL	PC	DCSM1F	JX5HW2X
DELL	Monitor	170SC	CN-00V538-64180-065- OX95

1.7 EUT Cable List and Details

Cable Description	Length (M)	Shielded/Unshielded	With Core/Without Core
N/A	N/A	N/A	N/A

2. SUMMARY OF TEST RESULTS

Description of Test	Result
§15.107 (a) Conducted Emission	Compliant
§15.109(a) Radiated Emission	Compliant

3. §15.107 (a)- CONDUCTED EMISSION

3.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is \pm 2.88 dB.

3.2 Test Equipment List and Details

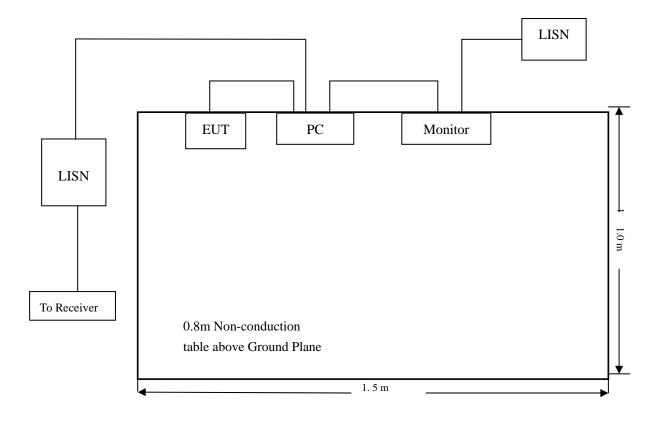
Description	Manufacturer	Model	Serial Number	Cal. Date	Due. Date
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2011-12-20	2012-12-19
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2011-12-20	2012-12-19
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2011-12-20	2012-12-19

3.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.107 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.

3.4 Basic Test Setup Block Diagram



3.5 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	52%
ATM Pressure:	1012 mbar

3.6 Test Receiver Setup

During the conducted emission test, the test receiver was set with the following configurations:

Start Frequency	150 kHz
Stop Frequency	30 MHz
Sweep Speed	Auto
IF Bandwidth	.10 kHz
Quasi-Peak Adapter Bandwidth	9 kHz
Quasi-Peak Adapter Mode	Normal

3.7 Summary of Test Results/Plots

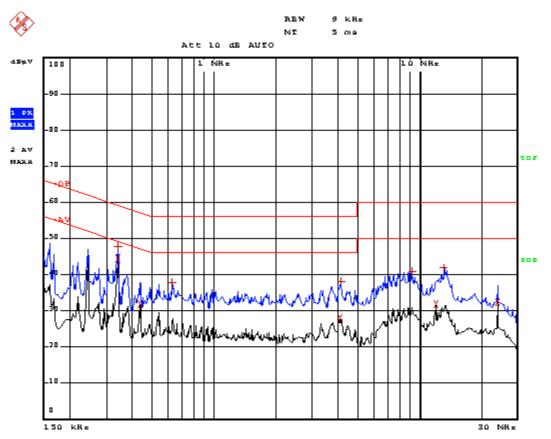
According to the data in section 3.8, the EUT <u>complied with the FCC Part 15B</u> Conducted margin for a Class B device, with the *worst* margin reading of:

-4.64 $dB\mu V$ at 0.338 MHz in the Neutral, Ave Detector, 0.15-30MHz

3.8 Conducted Emissions Test Data

Plot of Conducted Emissions Test Data

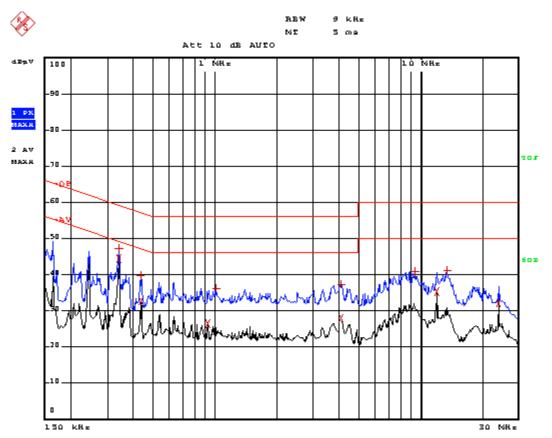
Conducted Disturbance EUT: Wireless N150 PCI Adapter M/N: ENLWI-1XN42 Operating Condition: Transmitting Test Specification: N Comment: AC 120V/60Hz; USB 5V



	EDIT PEAK LIST	(Prescan Results)		
Tracel:	– 06	- 06		
IraceZ:	- AV	-AV		
Irace3:				
TRACE	FRE QUENCY	LEVEL dBpV	DELTA LIMIT dE	
1 Nax Peak	338 kH±	47.83	-11.41	
Z Avezage	338 kH±	44.60	-4.64	
Z Avezage	434 kH±	31.85	-15.31	
1 Nax Peak	626 kH±	37.82	-18.17	
Z Avezage	4.126 MHz	28.00	-18.00	
1 New Peak	4.17 MH±	38.11	-17.88	
1 Max Peak	9.23 MH±	40.90	-19.09	
Z Avezage	11.994 MH±	31.88	-18.12	
1 Max Peak	13.186 MH±	41.77	-18.22	
Z Avezage	23.986 MH±	32.33	-17.46	

Plot of Conducted Emissions Test Data

Conducted Disturbance EUT: Wireless N150 PCI Adapter M/N: ENLWI-1XN42 Operating Condition: Transmitting Test Specification: N Comment: AC 120V/60Hz; USB 5V



	EDIT PEAK LIST (Prescan Results) —	
Tracel:	- 06		
IzaceZ:	-AV		
Izace3:			
TRACE	FRE QUENCY	LEVEL dEpV	DELTA LIMIT de
1 Nex Peak	338 kH±	47.42	-11.82
Z Avezage	338 kH±	44.32	-4.73
1 Nex Peak	434 kHz	39.74	-17.42
Z Avezage	434 kHz	32.69	-14.48
Z Avezage	922 kH±	Z6.30	-19.69
1 Nax Peak	1.022 MHz	36.18	-19.81
1 Nex Peak	4.114 MHz	37.28	-18.71
Z Average	4.134 MHz	27.94	-18.03
1 Nex Peak	9.438 MHz	40.94	-19.03
Z Avezage	11.994 MH±	33.39	-14.60
1 Nax Peak	13.61 NHz	41.04	-18.93
Z Avezage	23.986 MH±	32.16	-17.84

4. §15.109(a)- RADIATED EMISSION

4.1 Measurement Uncertainty

Base on NIS 81, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any radiation emissions measurement is ± 5.10 dB.

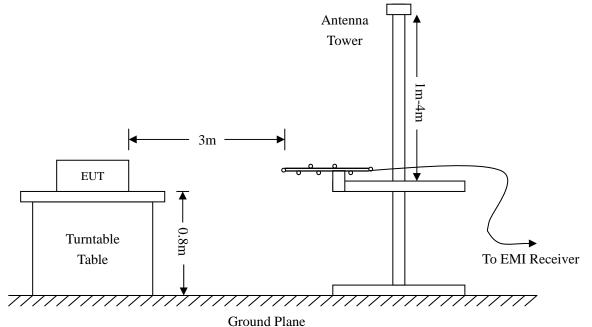
Description	Manufacturer	Model	Model Serial Number		Due. Date
Spectrum Analyzer	R&S	FSP	836079/035	2011-12-20	2012-12-19
EMI Test Receiver	R&S	ESVB	825471/005	2011-12-20	2012-12-19
Positioning Controller	C&C	CC-C-1F	N/A	2011-12-20	2012-12-19
RF Switch	EM	EMSW18	SW060023	2011-12-20	2012-12-19
Pre-amplifier	Agilent	8447F	3113A06717	2011-12-20	2012-12-19
Pre-amplifier	Compliance Direction	PAP-0118	24002	2011-12-20	2012-12-19
Trilog Broadband Antenna	SCHWARZBECK	VULB9163	9163-333	2012-01-09	2013-01-08
Horn Antenna	ETS	3117	00086197	2012-01-09	2013-01-08
Loop Antenna	SCHWARZECK	HFRA 5165	9365	2012-01-09	2013-01-08

4.2 Test Equipment List and Details

4.3 Test Procedure

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.205 and FCC Part 15.109 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.



4.4 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading – Corr. Factor

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of $-6dB\mu V$ means the emission is $6dB\mu V$ below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – FCC Part 15B Limit

The emission limit in this paragraph is based on measurement instrumentation employing an average detector. The provisions in \$15.35 for limiting peak emissions apply. Spurious Radiated Emissions measurements starting below or at the lowest crystal frequency.

4.5 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

4.6 Summary of Test Results/Plots

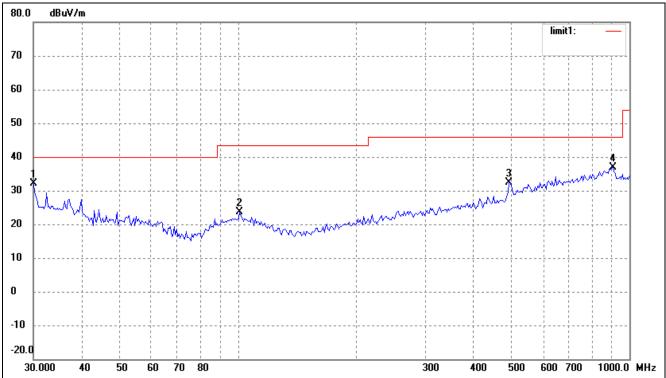
According to the data, the <u>EUT complied with the FCC Part 15B Class B</u> standards, and had the worst margin of:

-6.87 dBµV at 958.7943MHz in the Vertical polarization, 30 MHz to 1 GHz, 3Meters

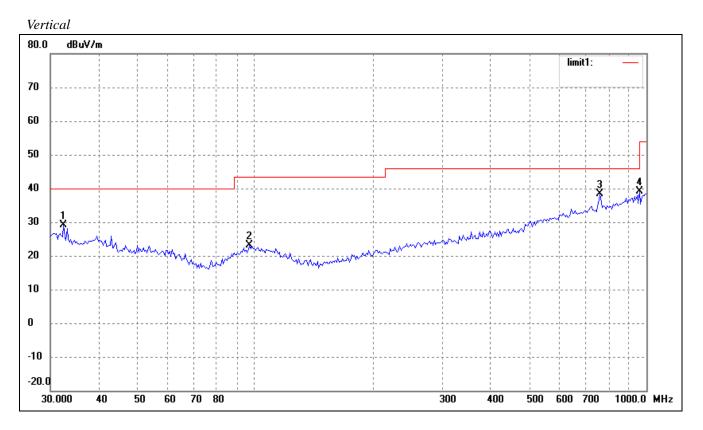
Plot of Radiation Emissions Test Data

Radiated Disturbance EUT: Wireless N150 PCI Adapter M/N: ENLWI-1XN42 Operating Condition: Operating Test Specification: Horizontal & Vertical Comment: AC 120V/60Hz

Horizontal



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	30.0000	25.24	6.77	32.01	40.00	-7.99	360	100	peak
2	100.9340	15.19	8.34	23.53	43.50	-19.97	360	100	peak
3	492.4685	18.77	13.67	32.44	46.00	-13.56	360	100	peak
4	906.4824	15.96	21.02	36.98	46.00	-9.02	360	100	peak



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV/m)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	32.4059	22.46	6.77	29.23	40.00	-10.77	360	100	peak
2	96.7749	14.88	8.19	23.07	43.50	-20.43	360	100	peak
3	760.7036	20.01	18.42	38.43	46.00	-7.57	360	100	peak
4	958.7943	17.15	21.98	39.13	46.00	-6.87	360	100	peak

Note: Testing is carried out with frequency rang 30MHz to the tenth harmonics, which above 5th Harmonics is close to the noise base even antenna close up to 1meter distance according the measurement of ANSI C63.4.

***** END OF REPORT *****